MCR716, MCR718

Preferred Device

Sensitive Gate Silicon Controlled Rectifiers

Reverse Blocking Thyristors

Designed for high volume, low cost, industrial and consumer applications such as motor control, process control, temperature, light and speed control.

Features

- Small Size
- Passivated Die for Reliability and Uniformity
- Low Level Triggering and Holding Characteristics
- Surface Mount Lead Form – Case 369C
- Epoxy Meets UL 94 V–0 @ 0.125 in
- ESD Ratings: Human Body Model, 3B > 8000 V
  Machine Model, C > 400 V
- Pb–Free Packages are Available

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Off–State Voltage (Note 1) (T_J = –40 to 110°C, Sine Wave, 50 to 60 Hz, R_{GK} = 1 kΩ) MCR716 MCR718	V_{DRM}, V_{RRM}	400 600	V
On–State RMS Current (180° Conduction Angles; T_C = 90°C)	$I_{T(RMS)}$	4.0	A
Average On–State Current (180° Conduction Angles; T_C = 90°C)	$I_{T(AV)}$	2.6	A
Peak Non-Repetitive Surge Current (1/2 Cycle, Sine Wave 60 Hz, T_J = 110°C)	I_{TSM}	25	A
Circuit Fusing Consideration (t = 8.3 msec)	I^2t	2.6	A^2sec
Forward Peak Gate Power (Pulse Width ≤ 1.0 μsec, T_C = 90°C)	P_{GM}	0.5	W
Forward Average Gate Power (t = 8.3 msec, T_C = 90°C)	$P_{G(AV)}$	0.1	W
Forward Peak Gate Current (Pulse Width ≤ 1.0 μsec, T_C = 90°C)	I_{GM}	0.2	A
Operating Junction Temperature Range	T_J	–40 to +110	°C
Storage Temperature Range	T_{stg}	–40 to +150	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. V_{DRM} and V_{RRM} for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

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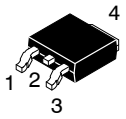
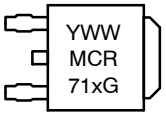
SCRs
4.0 AMPERES RMS
400 – 600 VOLTS



DPAK
CASE 369C
STYLE 4

MARKING DIAGRAM



Y = Year
WW = Work Week
MCR71x = Device Code
x= 6 or 8
G = Pb–Free Package

PIN ASSIGNMENT	
1	Cathode
2	Anode
3	Gate
4	Anode

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

Preferred devices are recommended choices for future use and best overall value.

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction−to−Case	$R_{\theta JC}$	3.0	°C/W
Thermal Resistance, Junction−to−Ambient (Note 2)	$R_{\theta JA}$	80	°C/W
Maximum Lead Temperature for Soldering Purposes 1/8″ from Case for 10 Seconds	T_L	260	°C

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted.)

Characteristic		Symbol	Min	Typ	Max	Unit
OFF CHARACTERISTICS						
Peak Repetitive Forward or Reverse Blocking Current; R_{GK} = 1 kΩ (Note 3)		I_{DRM}				μA
(V_{AK} = Rated V_{DRM} or V_{RRM})	T_C = 25°C	I_{RRM}	–	–	10	
	T_C = 110°C		–	–	200	
ON CHARACTERISTICS						
Peak Reverse Gate Blocking Voltage (I_{GR} = 10 μA)		V_{RGM}	10	12.5	18	V
Peak Reverse Gate Blocking Current (V_{GR} = 10 V)		I_{RGM}	–	–	1.2	μA
Peak Forward On−State Voltage (Note 4)		V_{TM}				V
(I_{TM} = 5.0 A Peak)			–	1.3	1.5	
(I_{TM} = 8.2 A Peak)			–	1.5	2.2	
Gate Trigger Current (Continuous dc) (Note 5)		I_{GT}				μA
(V_D = 12 Vdc, R_L = 30 Ω)	T_C = 25°C		1.0	25	75	
	T_C = −40°C		–	–	300	
Gate Trigger Voltage (Continuous dc) (Note 5)		V_{GT}				V
(V_D = 12 Vdc, R_L = 30 Ω)	T_C = 25°C		0.3	0.55	0.8	
	T_C = −40°C		–	–	1.0	
	T_C = 110°C		0.2	–	–	
Holding Current (Note 3)		I_H				mA
(V_D = 12 Vdc, Initiating Current = 20 mA, R_{GK} = 1 kΩ)	T_C = 25°C		0.4	1.0	5.0	
	T_C = −40°C		–	–	10	
Latching Current (Note 3) (R_{GK} = 1 kΩ)		I_L				mA
(V_D = 12 Vdc, I_G = 2.0 mA, T_C = 25°C)			–	–	5.0	
(V_D = 12 Vdc, I_G = 2.0 mA, T_C = −40°C)			–	–	10	
Total Turn-On Time		t_{gt}	–	2.0	5.0	μs
(Source Voltage = 12 V, R_S = 6 kΩ, I_T = 8 A(pk), R_{GK} = 1 kΩ)						
(V_D = Rated V_{DRM}, Rise Time = 20 ns, Pulse Width = 10 μs)						
DYNAMIC CHARACTERISTICS						
Critical Rate of Rise of Off−State Voltage		dv/dt	5.0	10	–	V/μs
(V_D = 0.67 x Rated V_{DRM}, R_{GK} = 1 kΩ, Exponential Waveform, T_J = 110°C)						
Repetitive Critical Rate of Rise of On−State Current		di/dt	–	–	100	A/μs
(f = 60 Hz, I_{PK} = 30 A, PW = 100 μs, dIG/dt = 1 A/μs)						

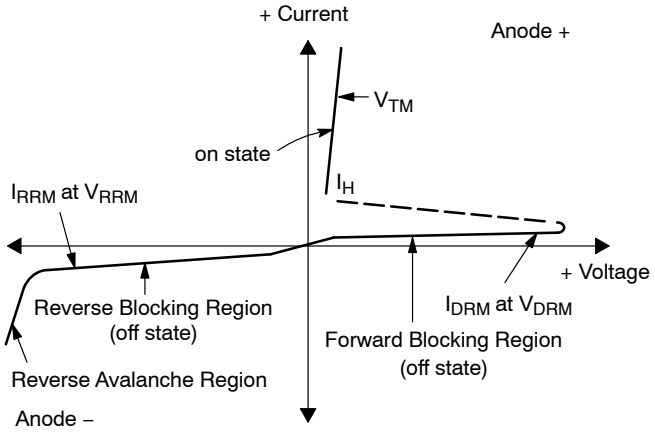
2. Case 369C, when surface mounted on minimum recommended pad size.
3. Ratings apply for negative gate voltage or R_{GK} = 1 kΩ. Devices shall not have a positive gate voltage concurrently with a negative voltage on the anode. Devices should not be tested with a constant current source for forward and reverse blocking capability such that the voltage applied exceeds the rated blocking voltage.
4. Pulse Test: Pulse Width ≤ 2 ms, Duty Cycle ≤ 2%.
5. R_{GK} current not included in measurements.

ORDERING INFORMATION

Device	Package	Shipping
MCR716T4	DPAK	2500 / Tape and Reel
MCR716T4G	DPAK (Pb−Free)	
MCR718T4	DPAK	
MCR718T4G	DPAK (Pb−Free)	

Voltage Current Characteristic of SCR

Symbol	Parameter
V_{DRM}	Peak Repetitive Off−State Forward Voltage
I_{DRM}	Peak Forward Blocking Current
V_{RRM}	Peak Repetitive Off−State Reverse Voltage
I_{RRM}	Peak Reverse Blocking Current
V_{TM}	Peak On−State Voltage
I_H	Holding Current



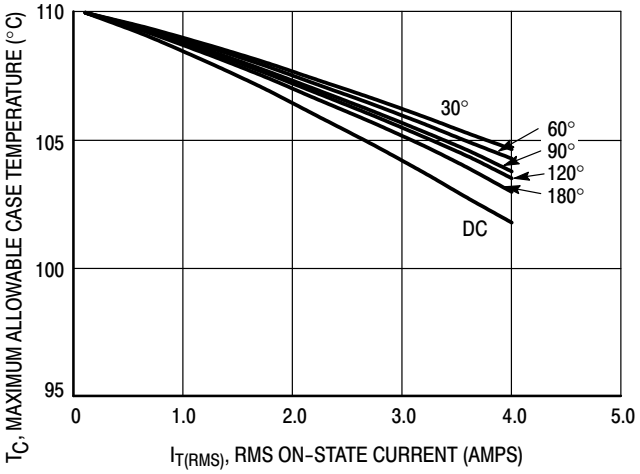


Figure 1. RMS Current Derating

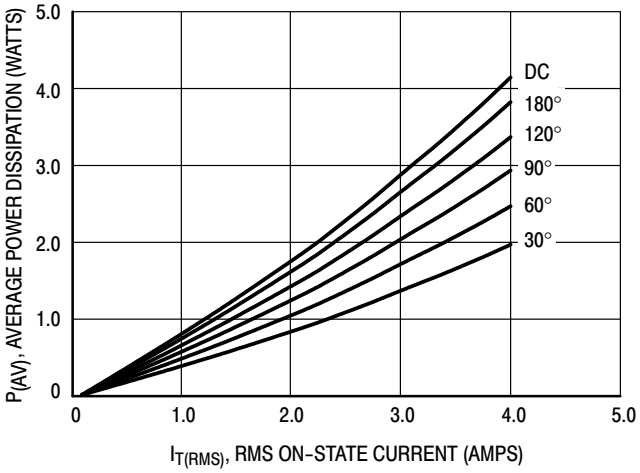


Figure 2. On−State Power Dissipation

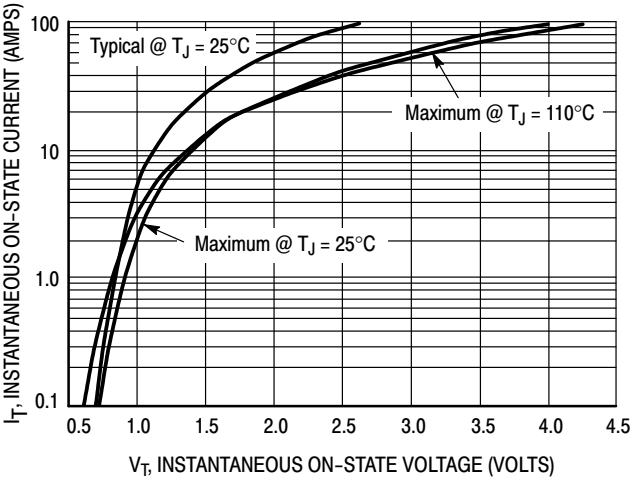


Figure 3. On−State Characteristics

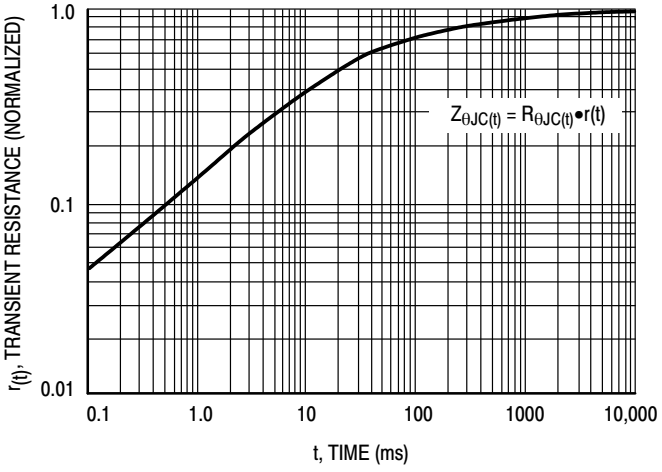


Figure 4. Transient Thermal Response

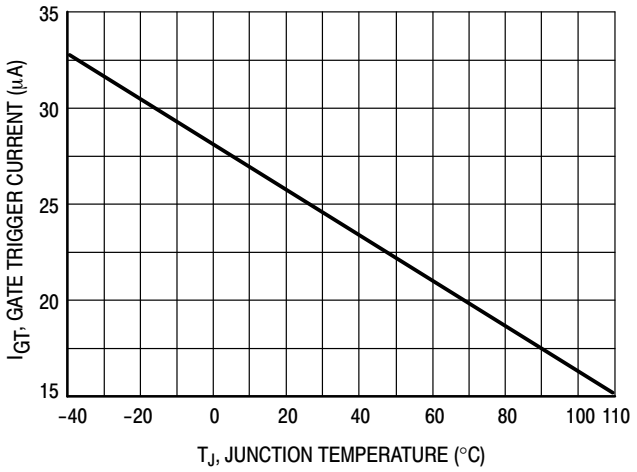


Figure 5. Typical Gate Trigger Current versus Junction Temperature

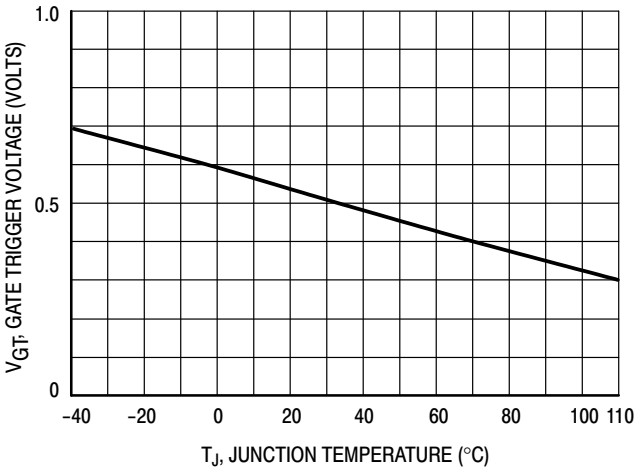


Figure 6. Typical Gate Trigger Voltage versus Junction Temperature

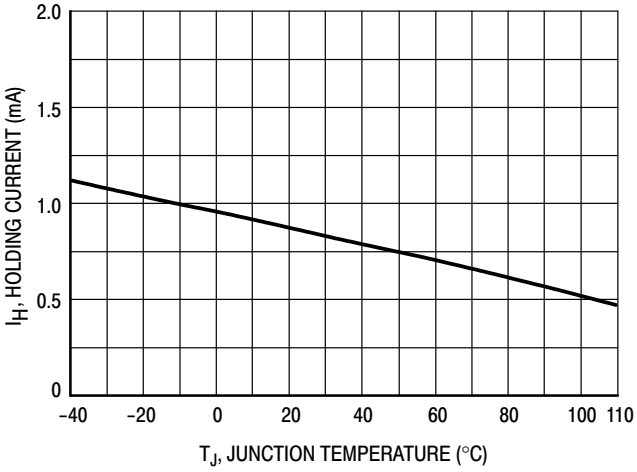


Figure 7. Typical Holding Current versus Junction Temperature

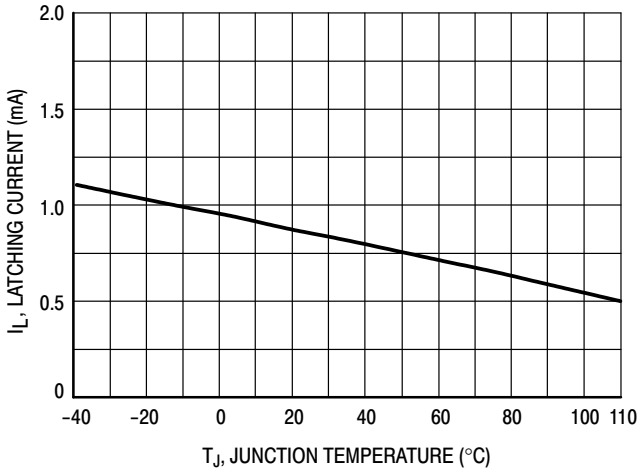
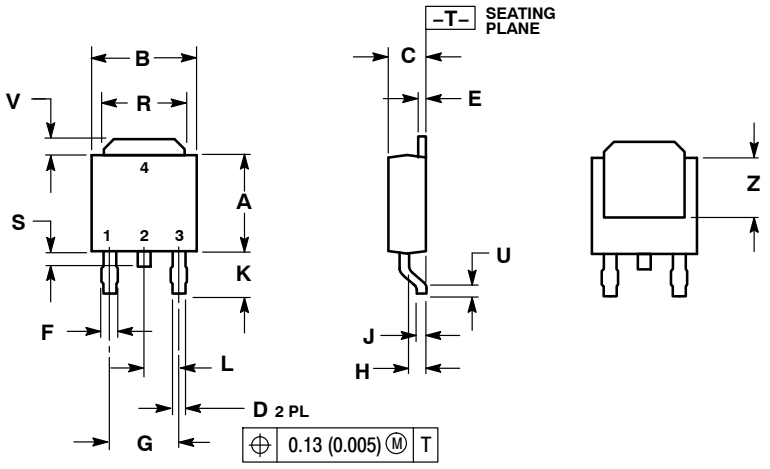


Figure 8. Typical Latching Current versus Junction Temperature

PACKAGE DIMENSIONS

DPAK
CASE 369C−01
ISSUE A

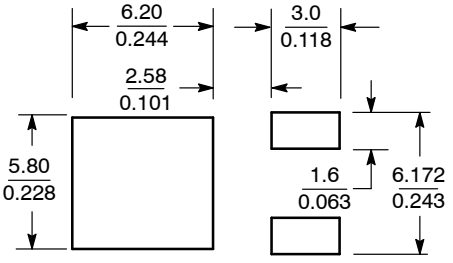


NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
A	0.235	0.245	5.97	6.22
B	0.250	0.265	6.35	6.73
C	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.180 BSC		4.58 BSC	
H	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.102	0.114	2.60	2.89
L	0.090 BSC		2.29 BSC	
R	0.180	0.215	4.57	5.45
S	0.025	0.040	0.63	1.01
U	0.020	−−−	0.51	−−−
V	0.035	0.050	0.89	1.27
Z	0.155	−−−	3.93	−−−

STYLE 4:
PIN 1. CATHODE
2. ANODE
3. GATE
4. ANODE

SOLDERING FOOTPRINT



SCALE 3:1 $\left(\frac{\text{mm}}{\text{inches}}\right)$

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